	Notice of References Cited	Application/Control No. 10/657,729	Applicant(s)/Patent Under Reexamination ETHRIDGE ET AL.	
		Examiner Mary C. Jacob	Art Unit 2123	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0215429	10-2004	Prabhu et al.	703/002
*	B	US-6,847,925	01-2005	Ottusch et al.	703/2
*	C	US-6,405,143	06-2002	Pham et al.	702/57
*	D	US-6,175,815	01-2001	Stalzer, Mark A.	703/5
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Murphy et al, "Numerical Second-Kind-Integral-Equation Solutions of Electromagnetic Scattering Problems", Electronics Letters, Vol. 25, No. 10, 11th May 1989, pages 643-644
	V	Igarashi et al, "A Boundary Element Analysis of Transmission-Line Parameters Using Singular Elements", IEEE Transactions on Magnetics, Vol. 32, No. 3, May 1996
	W	Mathworld (http://mathworld.wolfram.com/Integrand.html)
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office
PTO-892 (Rev. 01-2001)   **Notice of References Cited**   Part of Paper No. 20060918